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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

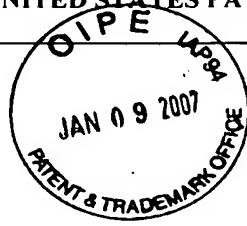
Applicant(s): DOI et al.

Serial No.: 10/653,075

Filed: September 3, 2003

Title: **CONTROL SYSTEM HAVING
ABNORMALITY MONITOR
FUNCTION**

Commissioner for Patents
Alexandria, VA 22313-1450



Atty. Dkt.: 01-465

Group Art Unit: 2154

Examiner: Unknown

Date: January 9, 2007

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Sir:

Pursuant to 37 C.F.R. §1.56, the reference(s) listed on the attached Form PTO-1449 is/are being brought to the attention of the Examiner without any admission that it/they constitute(s) statutory prior art, or without any admission that it/they contain(s) subject matter that anticipates the invention or renders the invention obvious to a person of ordinary skill in the art.

Further, pursuant to 37 C.F.R. §1.97(e), the undersigned hereby certifies that each listed reference was first cited in a Communication (copy and English translation enclosed) from a foreign patent office in connection with a counterpart foreign application not more than three months prior to the filing of this statement.

Although no fees are believed to be due at this time, it is respectfully requested that any such fees be charged to Deposit Account 50-1147. Also, the Examiner is requested to initial the attached PTO Form-1449 and to return a copy of same to the undersigned attorney as proof that the listed reference(s) has/have been considered and made of record.

Respectfully submitted,

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FORM PTO-1449	ATTY. DKT NO. 01-465	SER. NO. 10/653,075
APPLICANT DOI et al.		
FILING DATE September 3, 2003	GROUP 2154	

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JAN 09 2007
PATENT & TRADEMARK OFFICE

REFERENCE DESIGNATION**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

FOREIGN PATENT DOCUMENTS**TRANSLATION**

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
										Eng. Abstract
		JP-A-04-260902	9/16/92	JAPAN						X
		JP-A-10-326109	12/8/98	JAPAN						X

* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

	Notice of Reason for Rejection from Japanese Patent Office issued on December 12, 2006 for the corresponding Japanese patent application No. 2002-267050 (a copy and English translation thereof)
EXAMINER	DATE CONSIDERED